

P-Ch MOSFET

General Description

The WST3401 is the highest performance trench P-Ch MOSFET with extreme high cell density , which provide excellent R_{DSON} and gate charge for most of the small power switching and load switch applications .

The WST3401 meet the RoHS and Green Product requirement, with full function reliability approved.

Features

- Advanced high cell density Trench technology
- Super Low Gate Charge
- Excellent CdV/dt effect decline
- Green Device Available

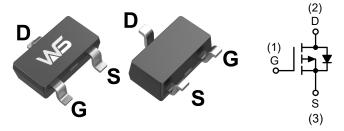
Product Summery

BV _{DSS}		I _D
-30V	44mΩ	-5.5A

Applications

- High Frequency Point-of-Load Synchronous Buck Converter for MB/NB/UMPC/VGA
- Networking DC-DC Power System
- Load Switch

SOT-23-3L Pin Configuration



Absolute Maximum Ratings

		Rating		
Symbol	Parameter	10s	Steady State	Units
V _{DS}	Drain-Source Voltage	-	V	
V _{GS}	Gate-Source Voltage	±	12	V
I _D @T _C =25℃	Continuous Drain Current, V _{GS} @ -10V ¹	-6.0	-5.5	А
I _D @T _C =70℃	Continuous Drain Current, V _{GS} @ -10V ¹	-4.9	-4.3	А
I _{DM}	Pulsed Drain Current ²	-17		А
P _D @T _A =25℃	Total Power Dissipation ³	1.32	1	W
P₀@T _A =70°C	Total Power Dissipation ³	0.84	0.64	W
T _{STG}	Storage Temperature Range	-55 t	-55 to 150	
TJ	Operating Junction Temperature Range	-55 t	-55 to 150	

Thermal Data

Symbol	Parameter	Тур.	Max.	Unit
R _{θJA}	Thermal Resistance Junction-Ambient ¹		125	°C/W
R _{θJA}	Thermal Resistance Junction-Ambient 1 (t \leq 10s)		95	°C /W
R _{eJC}	Thermal Resistance Junction-Case ¹		80	°C/W



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Electrical Characteristics (T_J=25 $^{\circ}$ C, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit	
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =-250uA	-30			V	
$\triangle BV_{DSS} / \triangle T_J$	BV _{DSS} Temperature Coefficient	Reference to 25 $^\circ\!\mathrm{C}$, I_D=-1mA		-0.023		V/℃	
D	Static Drain-Source On-Resistance ²	V _{GS} =-10V , I _D =-3A		44	52	- mΩ	
R _{DS(ON)}	Static Drain-Source On-Resistance	V _{GS} =-4.5V , I _D =-2A		50	58	1115.2	
V _{GS(th)}	Gate Threshold Voltage			-0.6	-1.2	V	
$ riangle V_{GS(th)}$	V _{GS(th)} Temperature Coefficient	VGS-VDS , ID2300A		4		mV/℃	
la se	Drain-Source Leakage Current	$V_{\text{DS}}\text{=-}24V$, $V_{\text{GS}}\text{=}0V$, $T_{\text{J}}\text{=}25^\circ\!\mathrm{C}$			-1		
I _{DSS}	Drain-Source Leakage Current	$V_{\text{DS}}\text{=-}24V$, $V_{\text{GS}}\text{=}0V$, $T_{\text{J}}\text{=}55^\circ\!\mathrm{C}$			-5	uA	
I _{GSS}	Gate-Source Leakage Current	V_{GS} = \pm 12V , V_{DS} =0V			±100	nA	
gfs	Forward Transconductance	V _{DS} =-5V , I _D =-3A		11		S	
Qg	Total Gate Charge (-4.5V)			6.4	9.0		
Q _{gs}	Gate-Source Charge	$V_{\text{DS}}\text{=-}15\text{V}$, $V_{\text{GS}}\text{=-}4.5\text{V}$, $I_{\text{D}}\text{=-}3\text{A}$		2.3	3.2	nC	
Q _{gd}	Gate-Drain Charge			1.9	2.7		
T _{d(on)}	Turn-On Delay Time			2.8	5.6		
Tr	Rise Time	$V_{DD}\text{=-}15V$, $V_{GS}\text{=-}10V$, $R_{G}\text{=}3.3\Omega,$		8.4	15.1	ns	
T _{d(off)}	Turn-Off Delay Time	I _D =-3A		6	12.0	115	
T _f	Fall Time			39	78.0		
C _{iss}	Input Capacitance			583	816		
Coss	Output Capacitance	V_{DS} =-15V , V_{GS} =0V , f=1MHz		100	140	pF	
C _{rss}	Reverse Transfer Capacitance			80	112		

Diode Characteristics

Symbol	Parameter Conditions		Min.	Тур.	Max.	Unit
ls	Continuous Source Current ^{1,4}				-4.3	А
I _{SM}	Pulsed Source Current ^{2,4}	$V_G = V_D = 0V$, Force Current			-17	А
V _{SD}	Diode Forward Voltage ²	V_{GS} =0V , I_{S} =-1A , T_{J} =25 $^{\circ}$ C			-1	V
trr	Reverse Recovery Time			7.8		nS
Qrr	Reverse Recovery Charge	IF=-3A , dI/dt=100A/µs , T _J =25 $^\circ \!\!\!\!\!\mathbb{C}$		2.5		nC

Note :

1. The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper,t<10sec,t<10sec.

2.The data tested by pulsed , pulse width $\,\leq\,$ 300us , duty cycle $\,\leq\,$ 2%

3.The power dissipation is limited by 150 $^\circ\!\mathrm{C}$ junction temperature

4. The data is theoretically the same as I_D and I_{DM} , in real applications, should be limited by total power dissipation.



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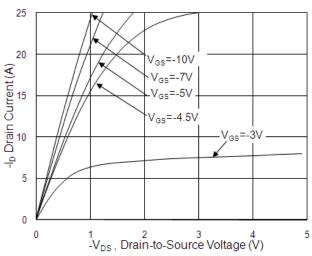


Fig.1 Typical Output Characteristics

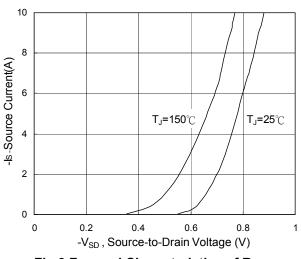
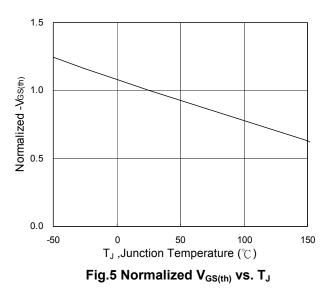


Fig.3 Forward Characteristics of Reverse



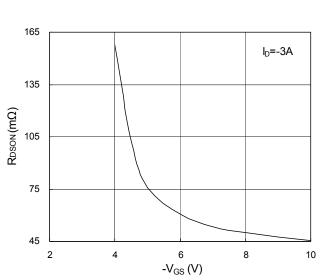


Fig.2 On-Resistance v.s Gate-Source

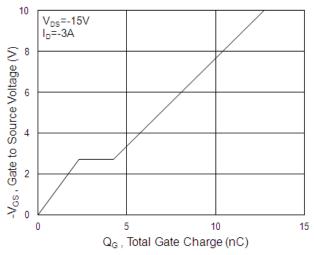
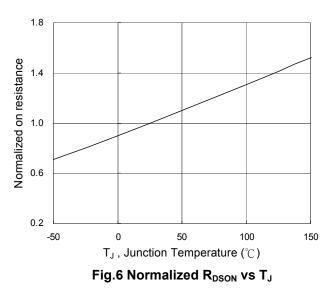


Fig.4 Gate-Charge Characteristics





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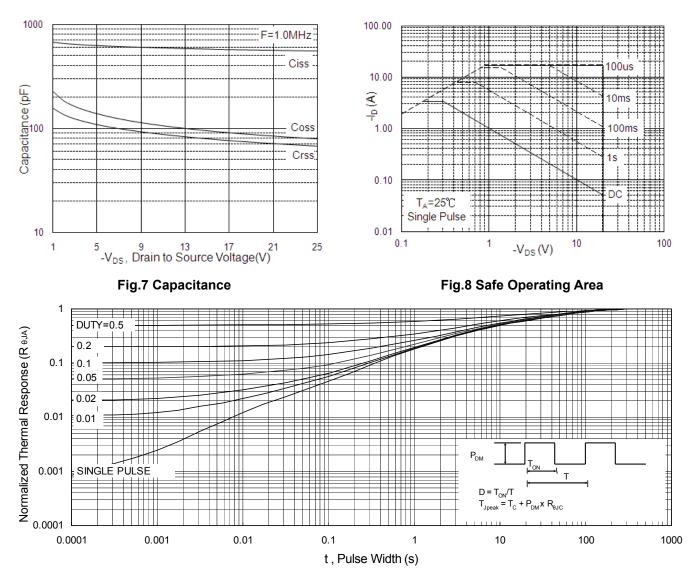
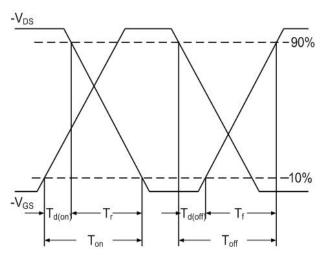
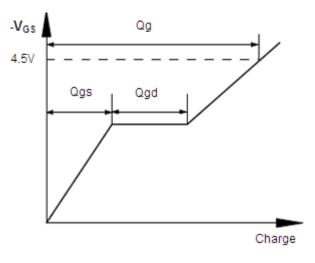


Fig.9 Normalized Maximum Transient Thermal Impedance







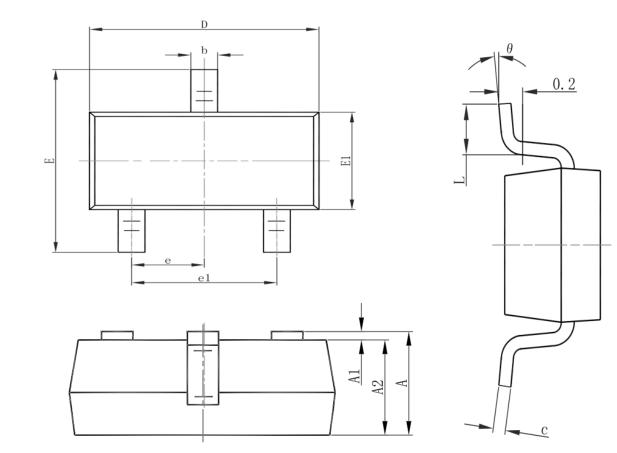




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WST3401

Packaging information



Complexel	Dimensions In Millimeters		Dimensions In Inches		
Symbol	Min.	Max.	Min.	Max.	
А	1.050	1.250	0.041	0.049	
A1	0.000	0.100	0.000	0.004	
A2	1.050	1.150	0.041	0.045	
b	0.300	0.500	0.012	0.020	
С	0.100	0.200	0.004	0.008	
D	2.820	3.020	0.111	0.119	
E1	1.500	1.700	0.059	0.067	
E	2.650	2.950	0.104	0.116	
е	0.950(BSC)		0.03	7(BSC)	
e1	1.800	2.000	0.071	0.079	
L	0.300	0.600	0.012	0.024	
θ	0°	8°	0°	8°	



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